EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	759	test$4 near5 (optical adj component)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:33
S2	107	golden near4 component	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:34
S3	2	S1 and S2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:34
S4	9286	324/753,765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:34
S5	7	S1 and S4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:36
S6	57213	test$4 near4 (integrated adj circuit or IC or chip)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:37
S7	0	S2 and S6	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:38
S8	31228	golden	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:38
S9	279	S6 and S8	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:38

S10	21	S4 and S9	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:46
S11	4431	324/765.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:46
S12	161303	switch and module	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:46
S13	199	S11 and S12	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:46
S14	106	S13 and wafer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:58
S15	76	S14 and (pass or fail)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:11
S16	26	probe adj card with module and switch	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:34
S17	84	S14 and compar$6	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 16:58
S18	2	("5600257" | "6480012").PN. OR ("6897666").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/19 17:10
S19	2728	324/754.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/19 17:10
S20	95	S12 and S19	US-PGPUB; USPAT; USOCR	OR	ON	2005/12/19 17:10
S21	86840	wafer and (pass or fail)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:11

S22	25	S20 and S21	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:19
S23	4431	324/765.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:20
S24	2066	S6 and S23	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:20
S25	2942364	compar$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:20
S26	1138	S24 and S25	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:20
S27	360	S21 and S26	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:24
S28	4103	324/754.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:25
S29	95	S12 and S28	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:25
S30	25	S21 and S29	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:34
S31	190	probe adj card and module and switch	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:34
S32	15348	324/754-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 17:35

S33	59	S31 and S32	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:00
S34	302	(integrated adj circuit or IC) near5 optical adj component	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:00
S35	1490	(integrated adj circuit or IC) near5 photodiode	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:14
S36	4431	324/765.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:01
S37	0	S36 and S35	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:01
S38	9286	324/753,765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:01
S39	6	S38 and S35	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:03
S40	21	test$4 near3 photo adj diode	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:07
S41	0	S40 and S38	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:03
S42	34	test$4 near3 photo adj sensor	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:11
S43	0	S42 and S38	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:07

S44	7912	DUT or device adj under adj test near3 photo adj diode	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:12
S45	0	(DUT or device adj under adj test) near3 photo adj diode	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:13
S46	11212	324/760-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:13
S47	1	S35 and S46	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:13
S48	1556	(integrated adj circuit or IC) near5 (photodiode or photo adj sensor)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:14
S49	3	S46 and S48	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/12/19 20:14
S50	8	(("5,923,176") or ("6,359,452") or ("5,910,957") or ("6,087,839")).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2005/12/19 20:45
S51	2	("5070297").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/07/02 16:15
S52	15987	324/754-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/02 16:15
S53	47	S52 and optical adj component	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/07/02 16:15
S54	5165	324/765.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:09

S55	919	test$4 near5 (optical adj component)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:09
S56	919	S55	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:10
S57	10	S54 and S55	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:13
S58	1	(larikova near2 julia).inv.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:14
S59	4	(wang near2 yajun).inv.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:15
S60	10307	324/753,765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:15
S61	10307	S60	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:15
S62	14	S55 and S61	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:18
S63	2273	pogo adj2 (pin or probe)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:18
S64	239	S54 and S63	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:47
S65	2	S55 and S64	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:18

S66	15	("20020080266" | "20030128442" | "4771230" | "4808815" | "5424573" | "6137303" | "6325552" | "6518656" | "6649832" | "6686588" | "6765396" | "6771846" | "6788083" | "6797936" | "6815729").PN. OR ("7129722").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/08 16:23
S67	15	test$4 with doubl$4 near5 head with (probe or pin)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:53
S68	291736	PCB or (printed adj circuit adj board)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:54
S69	763	S54 and S68	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:54
S70	5617	324/754,761,762.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:54
S71	163	S69 and S70	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/08 16:54
S72	609	324/767.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/10 14:30
S73	24189	photo adj1 diode	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/10 14:31
S74	8	S72 and S73	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/10 14:33
S75	782	test$4 near5 (photo adj1 diode or photodiode or photo adj1 transitor or phototransitor)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/10 14:34

S76	9	S72 and S75	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/10 14:34
S77	23	("4646005" | "4673885" | "4709141" | "4923407" | "5012186" | "5270660" | "5323115" | "5506515" | "5565788" | "5661396" | "5699530" | "5869975" | "5963058" | "6125217" | "6140883" | "6566854").PN. OR ("6856129").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 14:47
S78	146	136/290.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 14:48
S79	34220	test$4 near5 optical	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 15:43
S80	1	S78 and S79	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 14:48
S81	2298624	test$4	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 15:43
S82	70	S78 and S81	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 15:44
S83	609	324/767.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 16:35
S84	12	S78 and S83	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 16:35
S85	15	("2827436" | "3108914" | "3184347" | "3320103" | "3390311" | "3440113" | "3711325").PN. OR ("3905836").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 16:45

S86	23875	"372"/$.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 16:45
S87	0	S78 and S86	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 16:46
S88	66300	"356"/$.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 16:46
S89	9	S78 and S88	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 16:56
S90	143	136/243.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 16:56
S91	33	S81 and S90	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 17:04
S92	11	S78 and S90	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/11 17:04
S93	153	test$4 near5 light adj bulb	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 19:59
S94	153	test$4 near5 light adj bulb	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 14:14
S95	42	S94 and probe	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 20:00
S96	7672	test$4 near5 (LED or (light adj emitting adj diode))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 20:54
S97	123715	"324"/$.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 20:54
S98	754	S96 and S97	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 20:55
S99	446843	probe	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 20:55

S100	289	S98 and S99	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 20:59
S101	466	Testing adj2 (LED or light adj emitting adj diode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 21:15
S102	53	S97 and S101	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 21:00
S103	78301	"362"/$.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 21:16
S104	15	S101 and S103	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/11 21:16
S105	162	test$4 adj5 light adj bulb	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:29
S106	513	high adj frequency adj probe	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:29
S107	466	Testing adj2 (LED or light adj emitting adj diode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:29
S108	466	S107	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:29
S109	0	S105 and S107	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:30
S110	466	S107 and S107	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:30

S111	0	S106 and S107	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:30
S112	446843	probe	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:30
S113	95	S107 and S112	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 15:30
S114	17	("3839781" | "4318587" | "4489477" | "4498730" | "4516837" | "4521069").PN. OR ("4775640").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2007/05/12 16:19
S115	8	((("5,923,176") or ("6,359,452") or ("5,910,957") or ("6,087,839")).PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/05/12 16:19
S116	0	high adj speed adj electrical adj component with (LED or light adj emitting adj diode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 17:11
S117	0	high adj speed adj component with (LED or light adj emitting adj diode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 17:11
S118	0	high-speed adj component with (LED or light adj emitting adj diode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 17:11
S119	3307	high adj1 speed with (LED or light adj emitting adj diode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 17:12
S120	7	S107 and S119	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 17:16
S121	2	("20040169520").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/05/12 17:32

S122	20	high adj speed adj electrical adj component	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 17:43
S123	2	("20040169250").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/05/12 17:42
S124	2	("20040169520").PN.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/05/12 19:28
S125	513	high adj1 frequency adj probe	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 19:28
S126	5621	324/754,761,762.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 19:28
S127	66	S125 and S126	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/05/12 19:29
S128	982	test$4 near5 (optical adj component)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/01 18:15
S129	10818	324/753,765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/01 18:15
S130	16	S128 and S129	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/01 18:15
S131	13252	324/760-765,158.1.ccls.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/01 18:15
S132	15	S128 and S131	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/02/01 18:16

S133	10	("5600257" | "6480012").PN. OR ("6897666").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/02/02 18:14
S134	82	("3473124" | "4061969" | "4244048" | "4344033" | "4772846" | "4777716" | "4780086" | "4801871" | "4937203" | "4975079" | "5012187" | "5128008" | "5134638" | "5148103" | "5172050" | "5173904" | "5210485" | "5224265" | "5228502" | "5241266" | "5279975" | "5307010").PN. OR ("5600257").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/02/02 18:18
S135	96	("4161692" | "4697143" | "4733172" | "4783625" | "4791363" | "4820976" | "4849689" | "4922192" | "4928061" | "5027063").PN. OR ("5148103").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/02/02 18:33
S136	2	("4,891,577").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2008/02/02 19:18

2/2/08 11:34:40 PM
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